

Notice of References Cited		Application/Control No. 10/787,120	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner Chuong A. Luu	Art Unit 2892	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C US-7,102,750	09-2006	Takami, Yoshio	356/432
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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